Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/560,281	TACHIBANA ET AL.
Examiner	Art Unit
Karen Cheng	1626

SEARCHED				
Class	Subclass	Date	Examiner	
548	301.7	1/6/2007	кс	
548	318.5	1/6/2007	кс	
	<del></del>			
-				
	- · · · · · · · · · · · · · · · · · · ·			
	,			
<del></del> -				
	,			
			·	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			
			İ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN Structure Search (see attached)	1/5/2007	кс
Inventor Name Search	1/5/2007	кс
EAST Search (see attached)	1/6/2007	кс